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JC12 Rec'd PCT/777 3 0 SEP 2005

PATENT APPLICATION

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re the Application of

Akira YAMAGUCHI et al.

Application No.: New U.S. National Stage of

PCT/JP04/004144

Filed: September 30, 2005 Docket No.: 125495

For: ELECTRODE LEVEL DIFFERENCE ABSORBING PRINT PASTE AND METHOD OF

PRODUCING ELECTRONIC DEVICE

INFORMATION DISCLOSURE STATEMENT

Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

Sir:

Pursuant to 37 CFR §1.56, the attention of the Patent and Trademark Office is hereby directed to the references listed on the attached PTO-1449. Unless otherwise indicated herein, one copy of each reference is attached. It is respectfully requested that the information be expressly considered during the prosecution of this application, and that the references be made of record therein and appear among the "References Cited" on any patent to issue therefrom.

- 1. This Information Disclosure Statement is being filed (a) within three months of the U.S. filing date of this non-CPA application, OR (b) before the mailing date of a first Office Action on the merits in the present application. No certification or fee is required.
- 2. Relevance of the non-English language reference 4 is discussed in the present specification.
- 3. References 1 and 8-14 were cited in the International Search Report. An English language version of the International Search Report is attached for the Examiner's information.
- 4. In accordance with 37 CFR §1.98(a)(2)(ii), copies of any U.S. patents and patent application publications are not attached.
- 5. English language Abstracts of the non-English language references 2, 3 and 5-11 are attached hereto.
- 6. A computer-generated English language translation of Japanese Patent Publications 2, 3 and 6-11 has been obtained from the website of the Japanese Patent Office ([http://www.jpo.go.jp]), and is attached, but has not been reviewed for accuracy.

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7. Reference 1 corresponds to references 11-14.

Respectfully submitted,

James A. Oliff

Registration No. 27,075

Thomas J. Pardini

Registration No. 30,411

JAO:TJP/cqc

Date: September 30, 2005

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Sheet 1 of 1

Form PTO-1449 (REV. 8-83)		US Dept. of Commerce PATENT & TRADEMARK OFFICE TION DISCLOSURE STATEMENT		ATTY DO	OCKET NO.	New	APPLICATION NO. New U.S. National Stage of PCT/JP04/004144		
(Use several sheets if necessary)				APPLICANTS Akira YAMAGUCHI et al.					
				FILING I	DATE er 30, 2005				
U.S. PATENT DOCUMENTS									
EXAMINER INITIAL		DOCUMENT NUMBER	DATE		NAMI	Е	CLASS	SUB CLASS	
	1)	US 2001/0006451 A1	07/05/2001		MIYAZAKI et al.				
FOREIGN PATENT DOCUMENTS									
		DOCUMENT NUMBER	DATE		COUNT	RY	CLASS	SUB CLASS	
	2)	JP A 10-67567 w/ abstract & trans	03/10/1998		JAPAN				
	3)	JP A 6-206756 w/ abstract & trans	07/26/1994		JAPAN				
	4)	JP A 56-94719	07/31/1981		JAPAN	47.0			
	5)	JP A 3-74820 w/ abstract	03/29/1991		JAPAN			<u> </u>	
	6)	JP A 9-106925 w/ abstract & trans	04/22/1997		JAPAN		, , <u>, , , , , , , , , , , , , , , , , </u>		
	7)	JP A 2001-237140 w/ abst. & trans	08/31/2001		JAPAN				
	8)	JP A 2002-43161 w/ abst. & trans	02/08/2002		JAPAN				
	9)	JP A 2002-43164 w/ abst. & trans	02/08/2002		JAPAN				
	10)	JP A 2002-313672 w/ abst. & trans	10/25/2002		JAPAN				
	11)	JP A 2001-232617 w/ abst. & trans	08/28/2001		JAPAN				
	12)	GB 2 357 280 A	06/20/2001		GREAT BRITAIN				
	13)	GB 2 370 568 A	07/0	3/2002	GREAT BRITAIN				
	14)	GB 370 569 A	07/03		GREAT BRITAIN				
OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, etc.)									
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EXAMINER /Yoshitoshi Takeuchi/						DATE CONSIDERED 10/07/2008			
Examiner: Initial if citation considered, whether or not citation is in conformance with M.P.E.P. 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.									